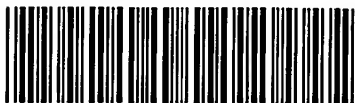


Search Notes

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10/664,931

Examiner

Richard H. Kim

Applicant(s)/Patent under
Reexamination

CHAE ET AL.

Art Unit

2871

SEARCHED

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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Text Search 349/\$; jpo,epo,uspat,pgpub-see printout	1/16/2006	RHK